

# Transient and AC conditions

- Time variation of stored charge.
  - Time dependant continuity equation
  - p+/n diode (figure 5-20 page 168)

$x_n(0) \rightarrow$  all hole current

$x_n(\infty) \rightarrow$  no hole current

$$i(t) = \frac{Q_p(t)}{\tau_p} + \frac{dQ_p(t)}{dt}$$

$$Q_p(t) = I\tau_p e^{-t/\tau_p}$$

# Transient and AC conditions

- Time variation of stored charge.
  - Quasi-steady state approximation

$$v(t) = \frac{kT}{q} \ln \left( \frac{I \tau_p}{q A L_p p_n} e^{-t/\tau_p} + 1 \right)$$

- To decrease switching time
  - decrease n-type region to less than  $L_p$  or decrease  $\tau_p$  (Au or Pt doping)

# Transient and AC conditions

- . Reverse recovery transient
  - This is a switching characteristic or large signal analysis (large deviations from a reference point).
  - Assume a p+/n diode biased with resistor R, driven by a square wave (+E to -E with period T)
    - Forward bias: For large E most of the voltage drops across the resistor and the current is given by  $I_f = E/R$ .

# Transient and AC conditions

- Reverse recovery transient
  - Sudden application of reverse bias:
    - Current initially becomes  $i = I_r = -E/R$  because the stored charge in the junction can not be removed instantly, therefore the voltage can not be changed instantly.
    - Once all the minority charge is gone the junction will become reversed biased and thus act like a large resistance because only the  $I_{gen}$  current is flowing.

# Transient and AC conditions

- Reverse recovery transient
  - Sudden application of reverse bias:
    - The time it takes for the junction voltage to become zero is  $t_{sd}$ . (figure 5-21 page 171)

$$t_{sd} = \tau_p \left[ \operatorname{erf}^{-1} \left( \frac{I_f}{I_f + I_r} \right) \right]^2$$

with the quasi - steady state approximation :

$$t_{sd} = \tau_p \ln \left( 1 + \frac{I_f}{I_r} \right)$$

# Transient and AC conditions

- Capacitance of p-n junctions
  - This is for small signal analysis. Assume a bias point and that the applied time varying voltage or current does not perturb the diode's G and C very far from their bias values.

# Transient and AC conditions

- Junction capacitance:
  - Dominant under reverse bias, due to separation of positive and negative charges.

$$W = \left[ \frac{2\epsilon(V_o - V)}{q} \left( \frac{N_a + N_d}{N_a N_d} \right) \right]^{\frac{1}{2}}$$

$$|Q| = qA \frac{N_a N_d}{N_a + N_d} W$$

$$C_j = \left| \frac{dQ}{d(V_o - V)} \right| = \frac{A}{2} \left[ \frac{2q\epsilon}{(V_o - V)} \frac{N_a N_d}{N_a + N_d} \right]^{\frac{1}{2}} = \frac{A\epsilon}{W}$$

# Transient and AC conditions

- Storage capacitance:
  - Dominant under forward bias, due to the voltage lagging behind the current.

$$G_s = \frac{dI}{dV} = \frac{q}{kT} I$$

$$C_s = \frac{dQ_p}{dV} = \frac{q}{kT} I \tau_p$$

$$i(ac) = G_s v(ac) + C_s \frac{dv(ac)}{dt}$$

# Example $C_j$ , $C_s$

- For the Si example calculate  $C_j$  at  $-2$ ,  $0$ , and  $0.5$  volts.
- For the Si example calculate  $C_s$  at  $-2$ ,  $0$ , and  $0.5$  volts.
- Minority lifetimes are  $1\mu\text{s}$ .

# Example Cj, Cs

kT/q (V)	Si $n_i$ (cm <sup>-3</sup> )	$N_D$ (cm <sup>-3</sup> )	$N_A$ (cm <sup>-3</sup> )	$V_0$ (V)	$\epsilon_r$ Si	$\epsilon_0$ F/cm <sup>2</sup>
0.025875	1.50E+10	1E+19	1E+16	0.872708	11.9	8.85E-14
0.025875	1.50E+10	1E+19	1E+16	0.872708	11.9	8.85E-14
0.025875	1.50E+10	1E+19	1E+16	0.872708	11.9	8.85E-14

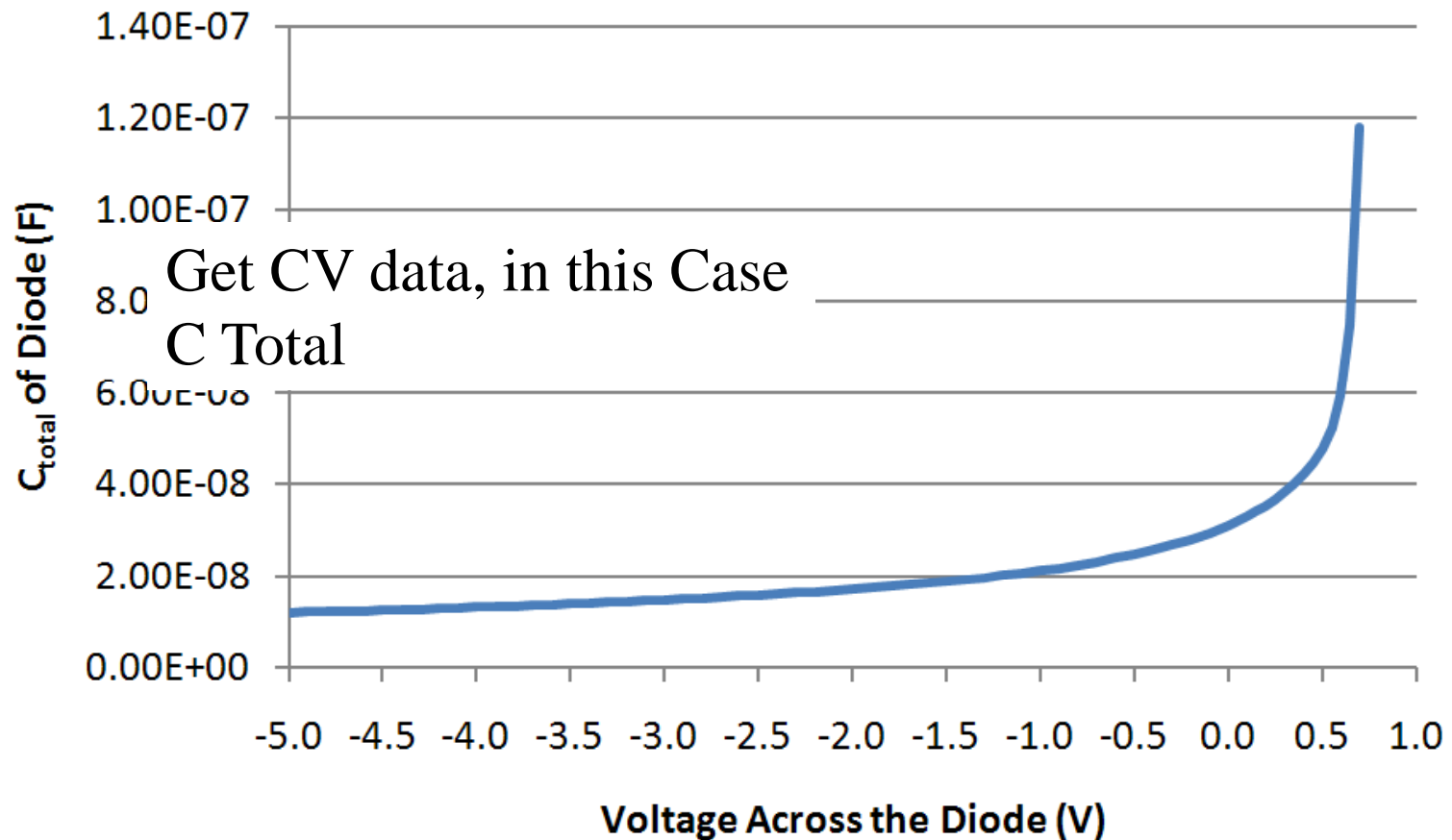
V Applied	$x_p$ (cm)	$x_n$ (cm)	W
-2.00E+00	6.14651E-05	6.14651E-08	6.15E-05
0.00E+00	3.3878E-05	3.3878E-08	3.39E-05
5.00E-01	2.21395E-05	2.21395E-08	2.22E-05

Area cm <sup>2</sup>	$\mu_n$ (cm <sup>2</sup> /Vs)	$\mu_p$ (cm <sup>2</sup> /Vs)	$\tau_n$ (s)	$\tau_p$ (s)	$D_n$ (cm <sup>2</sup> /s)	$D_p$ (cm <sup>2</sup> /s)	$L_n$ (cm)	$L_p$ (cm)
1.00E+00	1000	100	1.00E-06	1E-06	25.875	2.5875	0.00509	0.00161
1.00E+00	1000	100	1.00E-06	1E-06	25.875	2.5875	0.00509	0.00161
1.00E+00	1000	100	1.00E-06	1E-06	25.875	2.5875	0.00509	0.00161

$n_i^2/N_A$ (cm <sup>-3</sup> )	$n_i^2/N_D$ (cm <sup>-3</sup> )	$J_n$ (A/cm <sup>2</sup> )	$J_p$ (A/cm <sup>2</sup> )	$I_{gen}$ (A)	$I$ (A)	$C_s = q/kT * I * \tau_n$ (F)	$C_j$ (F)
2.25E+04	2.25E+01	1.14E+08	3.62E+04	1.83E-11	-1.83E-11	0.00E+00	1.71E-08
2.25E+04	2.25E+01	1.14E+08	3.62E+04	1.83E-11	0.00E+00	0.00E+00	3.11E-08
2.25E+04	2.25E+01	1.14E+08	3.62E+04	1.83E-11	4.52E-03	1.75E-07	4.75E-08

# Get CV data, in this case

## $C_{\text{Total}}$



# Plot 1/C<sup>2</sup> vs. Voltage

$$C_j = \frac{A}{2} \left[ \frac{2q\epsilon}{V_0 - V} N_{\text{substrate}} \right]^{\frac{1}{2}}$$

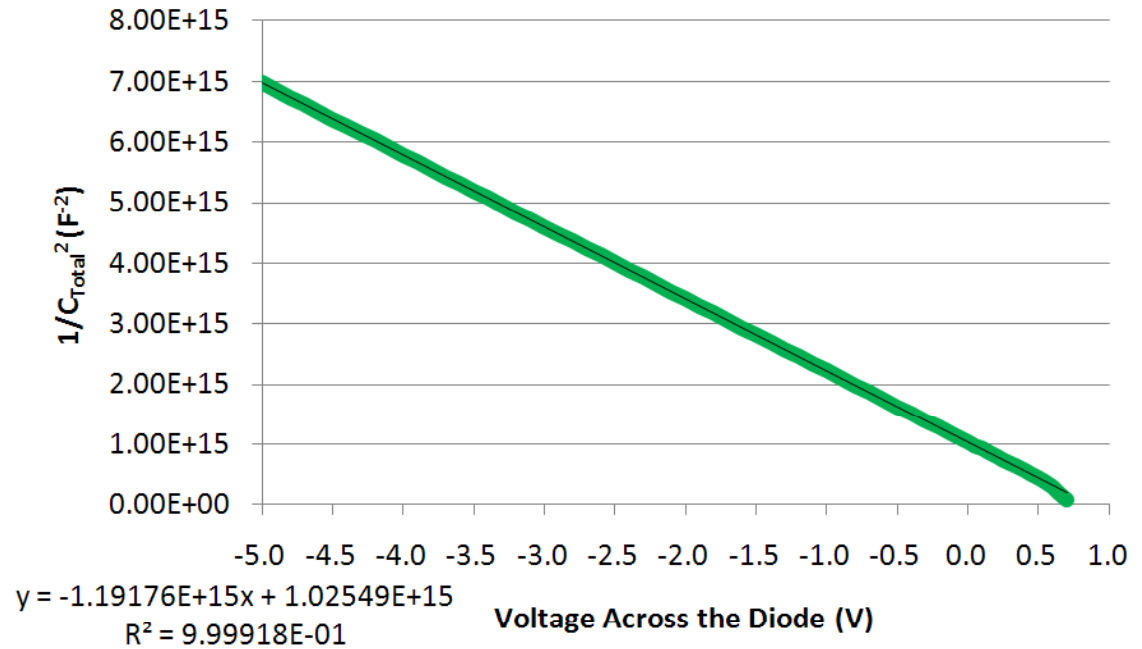
$$\frac{1}{C_j^2} = \frac{4}{A^2 2q\epsilon N_{\text{substrate}}} (V_0 - V)$$

$$y = \frac{1}{C_j^2} = \frac{-2V}{A^2 q\epsilon N_{\text{substrate}}} + \frac{V_0}{A^2 q\epsilon N_{\text{substrate}}}$$

$$y = mx + b$$

$$m = \frac{-2}{A^2 q\epsilon N_{\text{substrate}}}$$

$$b = \frac{2V_0}{A^2 q\epsilon N_{\text{substrate}}}$$



$$N_{\text{substrate}} = \frac{-2}{A^2 q\epsilon m} = 9.96 \times 10^{15} \text{ cm}^{-3}$$

$$V_0 = \frac{b A^2 q\epsilon N_{\text{substrate}}}{2}$$

$$V_0 = \frac{-b}{m} = \frac{-1.02549 \times 10^{15}}{-1.19176 \times 10^{15}} = .86V$$